

Application/Control No.	Applicant(s)/Patent under Reexamination
10/642 597	MAY FT AI

MAY ET AL

Tam M. Nguyen

Examiner

MALEI AL.	
Art Unit	
1764	

SEARCHED				
Class	Subclass	Date	Examiner	
585	351 864	4/16/2006	TN	
554	207 206	4/16/2006	TN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	4/13/2006	TN	
INTERFERENCE SEARCHED - SEE PGPUB- PRINTOUT	4/1/2006	TN	
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